Status of MAPS ECAL Simulation

19th January 2007 at Rutherford Appleton Laboratory

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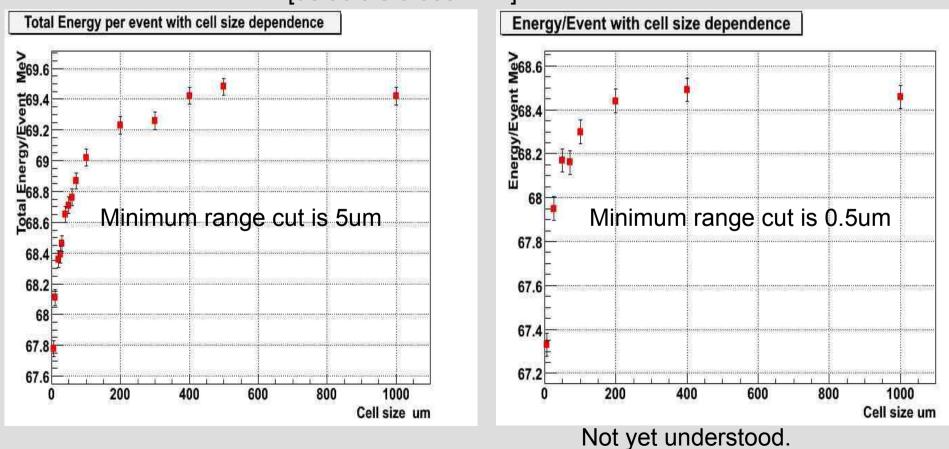
Contents: following up last year's issues -Minimum range cut effect in small cell cases -Weighted mean for number of cell hits -Linearity up to 400 GeV single electron -B fields effect -Energy resolution without charge diffusion -36&48 contiguous cell hit patterns -Next steps

Minimum range cut effect

In the steering file: /Mok

#/Mokka/init/rangeCut 0.005 mm

- Mokka/init/rangeCut 0.0005 mm
 - # specifies the production Geant4 range cut
 - # [default is 0.005 mm]

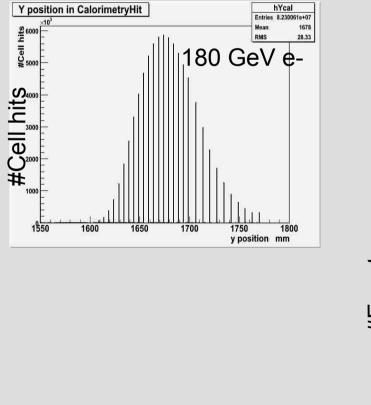


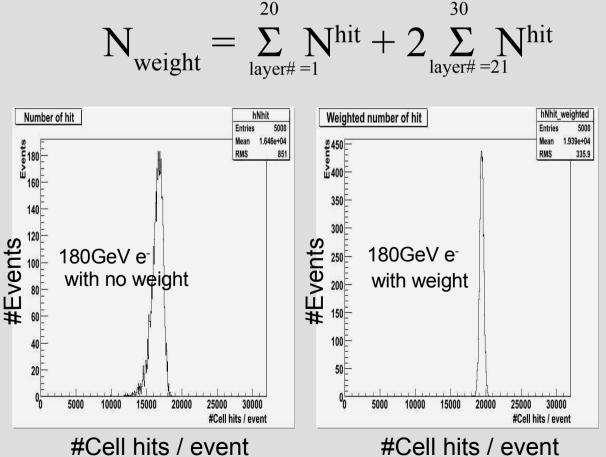
Geant4 cell boundary effect ??

Weighted #Cell hits

W thickness: 2.1mm for first 20 layers 4.2mm for last 10 layers

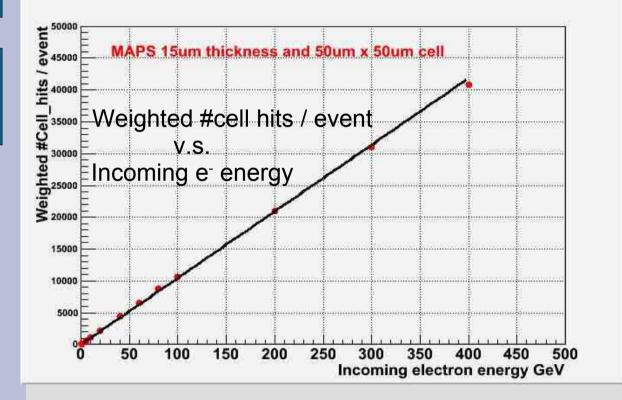
Longitudinal shower shape in 30layers:





Linearity for #cell hits

- 50µm X 50µm cell size
- B fields is off
- Charge diffusion is not yet added.



Linearity for #cell hits

- 50µm X 50µm cell size
- B fields is off

hit energy

Cell hits 009 #Cell

> 500 400

> 300

100

×10

• Charge diffusion is not yet added.

400 GeV single e-

Cell hit energy

, and a set of the set

hEhit_3 s 1.637429e+0

RMS

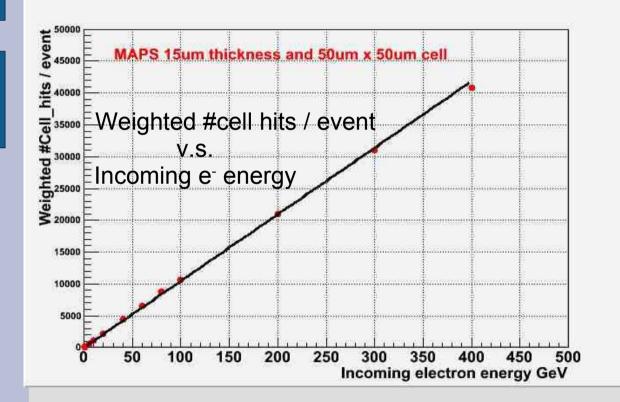
4.351e-00

2.2796-0

×10⁻⁶

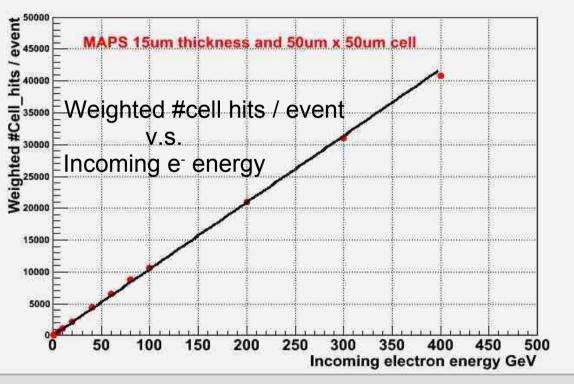
GeV

Cell hit energy



• 50µm X 50µm cell size • B fields is off Charge diffusion is not yet added. hit energy hEhit 3 637429e+ 400 GeV single e-4.351e-00 Cell hits 009 #Cell DMS 2.2796-0 MAPS 15um thickness and 50um x 50um cell **Cell** hit energy 500 400 Weighted #cell hits / event 300 200 V.S. 100 Incoming e- energy Cell hit energy GeV Y position in CalorimetryHit hYcal Entries 1.637429e+08 ×10° 1685 12 RMS 28.68 400 GeV single e-10 * Hongitudinal shower shape 50 100 200 250 300 350 500 150 400 450 Incoming electron energy GeV 1550 1600 1800 1650 1700 1750 **Energy leak**

Linearity for #cell hits



• 50µm X 50µm cell size • B fields is off Charge diffusion is not yet added. hit energy 10000 tube 45000 400 GeV single e-4.351e-0 £700 192 4600 MAPS 15um thickness and 50um x 50um cell Cell hit energy 500 hits 40000 400 Veighted #Cell 320000 50000 50000 50000 50000 Weighted #cell hits / event 300 35000 200 V.S. 30000 100 Incoming e⁻ energy 4 5 6 7 8 9 **Cell hit energy** GeV Y position in CalorimetryHit hYcal 1.637429e+0 ×10' 1685 12 15000 RMS 28.68 400 GeV single e-10 10000 * Hongitudinal 5000 shower shape 50 100 200 500 150 250 300 350 400 450 Incoming electron energy GeV hNhit_weighted Weighted number of hit hNhit weighted Weighted number of hit 5000 Entries Entries 5000 1.067e+04 Mean 4.079e+04 Mean RMS 189.6 PMS 498.9 600 350 1550 1600 1650 1700 1750 1800 300 500 250 400 100 GeV e-400 GeV e-200 Weighted #cell hits / event 300 Weighted #cell hits / event 150 Energy leak 200 100 100 50 030000 9000 10000 11000 12000 13000 35000 40000 45000 50000

Linearity for #cell hits

Energy resolution and B field effect (1)

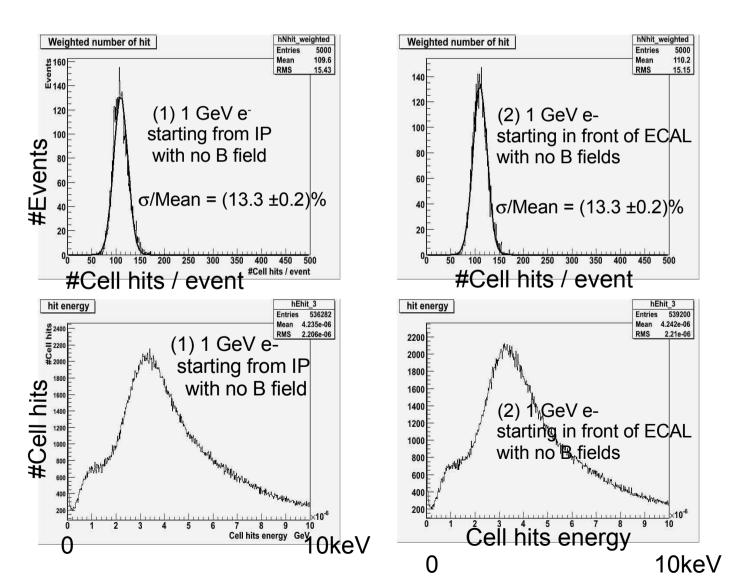
1 GeV electron energy resolutions:

(1) With no B field and starting the e from IP:

- $50\mu m X 50\mu m$ cell size
- Charge diffusion is not yet added.
- No noise and no threshold

σ/Mean = 14.6/109.6 = (13.3 ± 0.2)%

(2) With no B field and starting the e⁻ right in front of the ECAL: σ /Mean = 14.6/110.4 = (13.3 ± 0.2)%

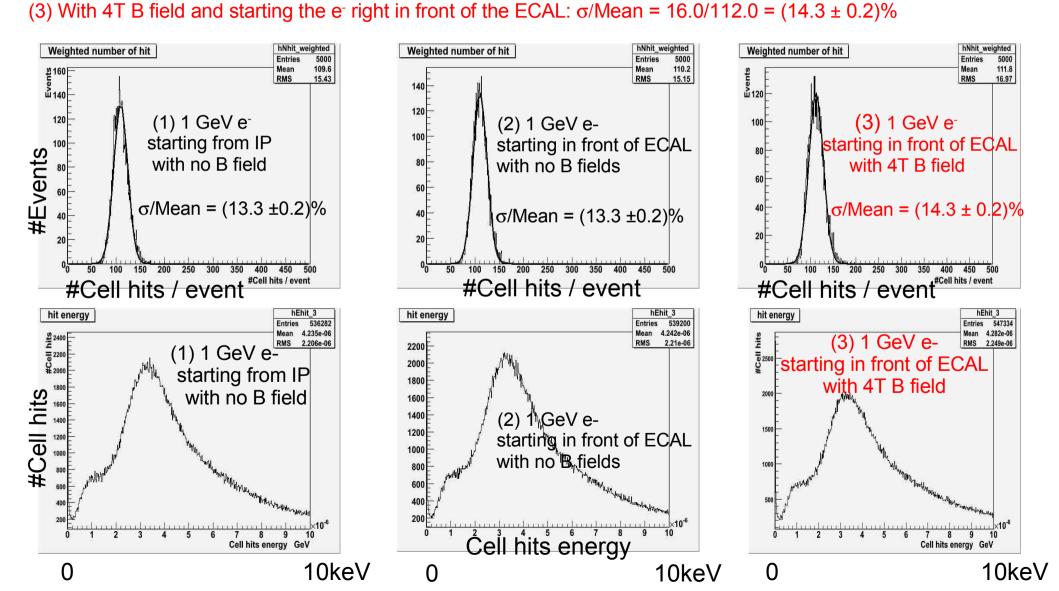


Energy resolution and B field effect (2)

1 GeV electron energy resolutions:

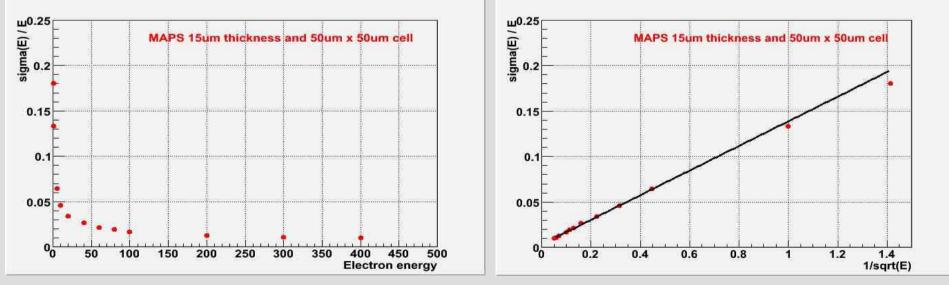
- 50µm X 50µm cell size
- Charge diffusion is not yet added.
- No noise and no thresholds

(1) With no B field and starting the e⁻ from IP: σ /Mean = 14.6/109.6 = (13.3 ± 0.2)% (2) With no B field and starting the e⁻ right in front of the ECAL: σ /Mean = 14.6/110.4 = (13.3 ± 0.2)%



Very preliminary energy resolution

- Single electron
- B field is off
- Counting number of cell hits in earn event without clustering. (i.e. It includes hits of radiated photons.)
- Weighted number of cell hits is used for different W thickness layers.
- Charge diffusion is not yet added. (Adding charge diffusion is essential to confirm whether only one hit per cell after diffusion.)
- No threshold is applied. (Almost the same cell hit energy distribution means almost the same efficiency for threshold applying -> The linearity could be represented again after threshold)
 No noise is applied. (It will be small effect after threshold application.)

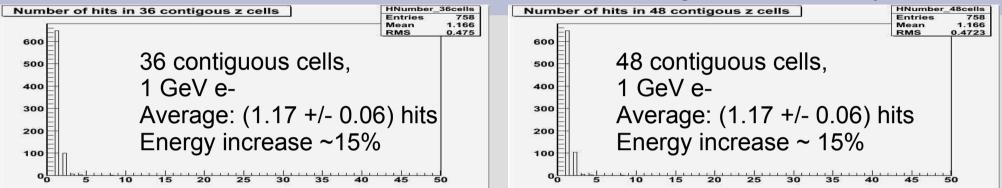


Fitting: $\sigma / E = (13.5 \pm 0.2)\% / \sqrt{E} + (0.35 \pm 0.02)\%$

E with Ge and using up to 400 GeV.

36 or 48 contiguous cell (in z direction) hit patterns

- 50µm X 50µm cell size
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36 or 48 contiguous cell (in z direction) hit patterns

- 50µm X 50µm cell size
- B fields is off
- Charge diffusion is not yet added. HNumber Number of hits in 36 contigous z cells Number of hits in 48 contigous z cells Entries 758 Entries 758 Mean 1.166 1.166 RMS 0.475 RMS 600 600 36 contiguous cells, 48 contiguous cells, 500 500 1 GeV e-1 GeV e-400 400 300 300 Average: (1.17 +/- 0.06) hits Average: (1.17 +/- 0.06) hits 200 200 Energy increase ~15% Energy increase ~ 15% 100 100 10 15 20 25 30 35 40 45 10 15 20 25 30 35 40 45 0 HNumber 36cells Number of hits in 48 contigous z cells HNumber 48cells Number of hits in 36 contigous z cells Entries 59099 Entries 57011 Mean 1 451 Mean 1 504 40000 RMS 9378 PMS 1.013 40000 35000 48 contiguous cells. 35000 36 contiguous cells, 30000 30000 100 GeV e-100 GeV e-25000 25000 20000 Average: (1.50 +/- 0.01)hits 20000 Average: (1.45 +/- 0.01) hits 15000 15000 Energy increase ~51% Energy increase ~ 45% 10000 10000 5000 5000 5 10 15 20 25 30 35 40 45 50 5 10 15 20 25 30 35 40 45 Number of hits in 36 contigous z cells Number 36cells Number of hits in 48 contigous z cells Entries 162260 Entries 152332 Mean 1.795 1.912 Mean 100 80 36 contiguous cells, 48 contiguous cells, 80 60 400 GeV e-400 GeV e-60 40 Average: (1.80 +/- 0.01) hits Average: (1.91 +/- 0.01) hits 40 Energy increase ~ 92% 20 Energy increase ~ 80%

• 36 and 48 has similar hit pattern -> Cell hits position will be close inside contiguous lines.

Average hit and energy increase ratio is similar. -> It will not be charge sharing hits but will be normal hits

Next steps

- Using dead area implementation
- Using Anne-Marie's codes for charge sharing compensation and charge diffusion compensation.
- Energy/Angle/Position resolutions
 - → Comparison between analogue v.s. digital
- Devoting on a clustering algorithm development
 - → e.g. Requiring high density with cylinder based topology